## Notice of References Cited Application/Control No. 09/955,764 Examiner J. Derek Rutten Applicant(s)/Patent Under Reexamination LI ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,956,509 A	09-1999	Kevner, Gene D.	719/330
	В	US-2002/0083211 A1	06-2002	Driesner et al.	709/311
	С	US-6,487,607 B1	11-2002	Wollrath et al.	719/330
	D	US-6,839,897 B2	01-2005	Takagi, Junji	719/330
	Ε	US-			
	F	US-		10.000	
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.